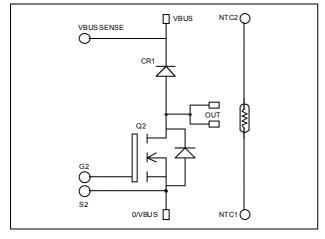


Boost chopper
SiC FWD diode
Super Junction
MOSFET Power Module



$$\begin{split} V_{DSS} &= 600 V \\ R_{DSon} &= 18 m \Omega \ max \ @ \ Tj = 25 ^{\circ} C \\ I_D &= 143 A \ @ \ Tc = 25 ^{\circ} C \end{split}$$

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

Features

COOLMOS Power Semiconductors

Till 1 D

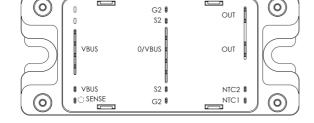
- Ultra low R_{DSon}
- Low Miller capacitance
- Ultra low gate charge
- Avalanche energy rated

• FWD SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant



Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		600	V
т	Continuous Durin Comment	$T_c = 25^{\circ}C$	143	
I_{D}	Continuous Drain Current	$T_c = 80^{\circ}C$	107	A
I_{DM}	Pulsed Drain current		572	
V_{GS}	Gate - Source Voltage		±30	V
R _{DSon}	Drain - Source ON Resistance		18	mΩ
P_{D}	Maximum Power Dissipation $T_c = 25^{\circ}C$		833	W
I_{AR}	Avalanche current (repetitive and non repetitive)		20	A
E _{AR}	Repetitive Avalanche Energy		1	mJ
E_{AS}	Single Pulse Avalanche Energy		1800	111,7

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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All ratings @ $T_j = 25$ °C unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 25^{\circ}C$			100	μА
		$V_{GS} = 0V, V_{DS} = 600V$ $T_j = 125^{\circ}C$			1000	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 71.5A$			18	mΩ
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 4mA$	2.1	3	3.9	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±200	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		28		
C_{oss}	Output Capacitance	$V_{DS} = 25V$		10.2		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		0.85		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		1036		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 300V$		116		nC
Q_{gd}	Gate – Drain Charge	$I_D = 143A$		444		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C		21		
$T_{\rm r}$	Rise Time	$V_{GS} = 15V$		30		na
$T_{d(off)}$	Turn-off Delay Time	$\begin{aligned} V_{Bus} &= 400V \\ I_D &= 143A \\ R_G &= 1.2\Omega \end{aligned}$		283		ns
T_{f}	Fall Time			84		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 15V$, $V_{Bus} = 400V$ $I_D = 143A$, $R_G = 1.2\Omega$		1608		1
E_{off}	Turn-off Switching Energy			3920		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V$, $V_{Bus} = 400V$ $I_D = 143A$, $R_G = 1.2\Omega$		2630		Ţ
E_{off}	Turn-off Switching Energy			4824	·	μJ

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
T	$I_{\rm DM}$ Maximum Reverse Leakage Current $V_{\rm D}=600{\rm V}$	V -600V	$T_j = 25^{\circ}C$		0.5	2	mA
1 _{RM}		$T_j = 175$ °C		1	10	ША	
I_F	DC Forward Current		Tc = 125°C		100		A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 100A$ $T_j = 25^{\circ}C$ $T_j = 175^{\circ}C$	$T_i = 25^{\circ}C$		1.6	1.8	V
v _F				2.0	2.4	V	
Qc	Total Capacitive Charge	$I_F = 100A, V_R = 300V$ di/dt =2400A/ μ s			140		nC
С	Total Compositors	$f = 1MHz, V_R = 200V$			650	650	F
	Total Capacitance	$f = 1MHz, V_R =$	= 400V		500		pF



Thermal and package characteristics

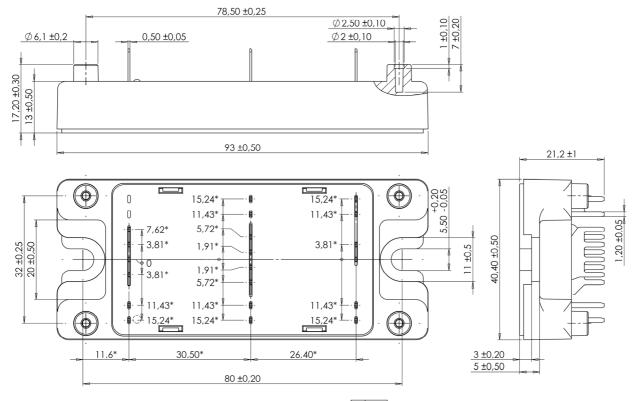
Symbol	Characteristic			Min	Тур	Max	Unit
R_{thJC}	Junction to Case Thermal Resistance		Transistor			0.15	°C/W
IX _{th} JC			Diode			0.28	C/ VV
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T_{J}	Operating junction temperature range			-40		150	
T_{STG}	Storage Temperature Range		-40		125	°C	
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M5	2.5		4.7	N.m
Wt	Package Weight				160	g	

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_{T} = \frac{R_{25}}{\exp\!\left[B_{25/85}\!\left(\frac{1}{T_{25}}\!-\!\frac{1}{T}\right)\right]} \quad \text{T: Thermistor temperature} \\ R_{T} : \text{Thermistor value at T}$$

SP4 Package outline (dimensions in mm)

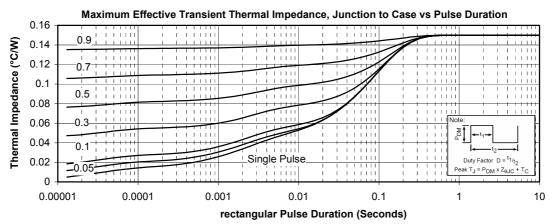


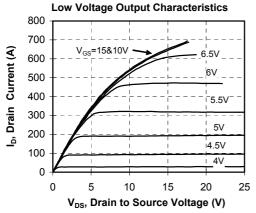
ALL DIMENSIONS MARKED "*" ARE TOLERANCED AS : + Ø 1

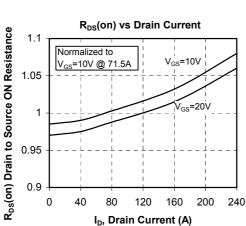
 $See \ application \ note \ APT0501 - Mounting \ Instructions \ for \ SP4 \ Power \ Modules \ on \ www.microsemi.com$

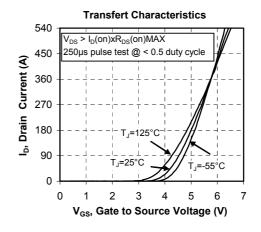


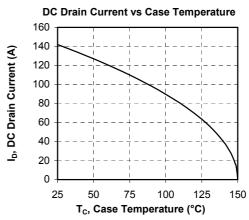
Typical CoolMOS Performance Curve





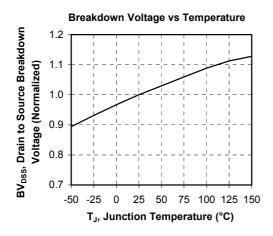


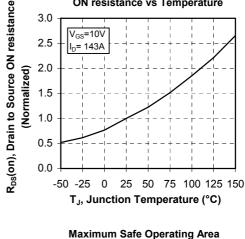


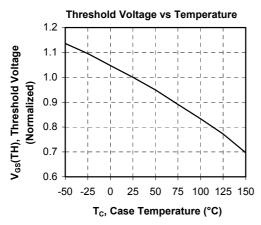


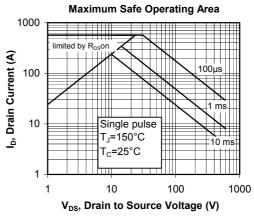


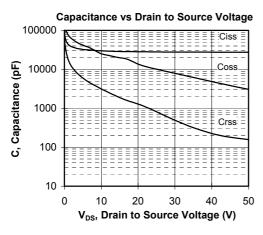
ON resistance vs Temperature

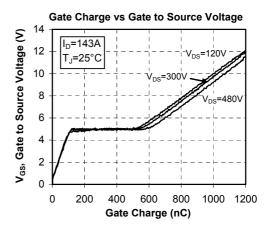




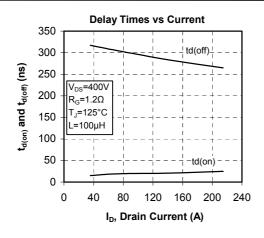


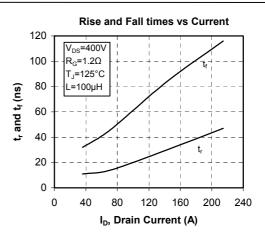


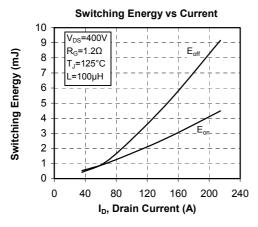


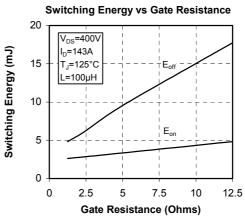


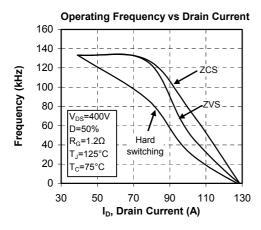


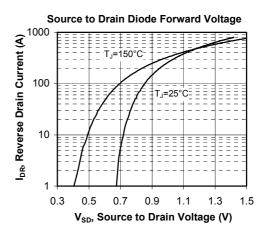






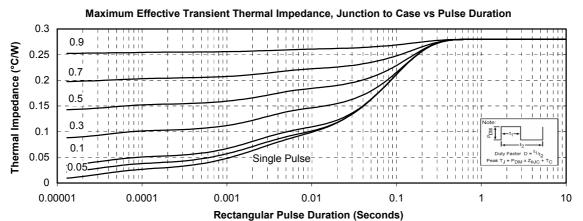


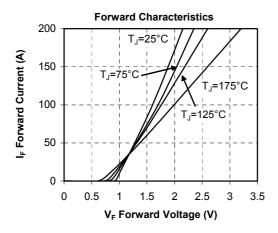


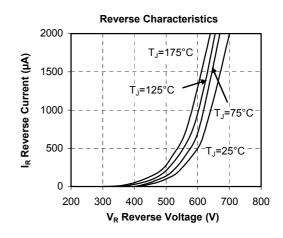


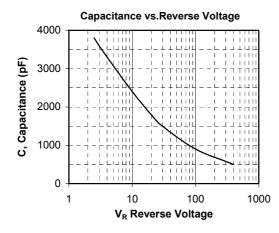


Typical SiC Diode Performance Curve









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